

IPC-WP-114A
2021 - October
**Guidance for the
Development and
Implementation of a
White Plague Control Plan
(WPCP)**

A White Paper Report Developed by IPC



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- Show relationship to Design for Manufacturability (DFM) and Design for the Environment (DFE)
- Minimize time to market
- Contain simple (simplified) language
- Just include spec information
- Focus on end product performance
- Include a feedback system on use and problems for future improvement

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- Increase time-to-market
- Keep people out
- Increase cycle time
- Tell you how to make something
- Contain anything that cannot be defended with data

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IPC-WP-114A

Guidance for the Development and Implementation of a White Plague Control Plan (WPCP)

Developed by the Wire Harness Design Task Group (7-31k)
of the Product Assurance Committee (7-30) of IPC

Supersedes:
IPC-WP-114 -
December 2015

Users of this publication are encouraged to participate in the
development of future revisions.

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Acknowledgment

Members of the Wire Harness Design Task Group worked to develop this document. We thank them for their dedication and service to this effort. Any document involving a complex technology draws material from a vast number of sources across many continents. While the principal members of the Wire Harness Design Task Group (7-31k) of the Product Assurance Committee (7-30) are shown below, it is not possible to include all of those who assisted in the evolution of this standard. To each of them, the members of the IPC extend their gratitude.

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Guidance for the Development and Implementation of a White Plague Control Plan (WPCP)

TECHNICAL BACKGROUND

During the manufacturing of fluoropolymer-insulated electrical wires and cables made with tin-coated, silver-coated, or nickel-coated conductors of copper or copper alloy, the extrusion of fluorocarbon resin occurs at a temperature high enough that oxidative degradation of the polymer will occur, resulting in the evolution or outgassing of a number of materials, including carbonyl fluoride (COF_2), an extremely reactive compound. This outgassing from the insulation jacket is both internal (to the wire strand/cable bundle) and external (to the surrounding environment).

Chemical Reaction – In the presence of trace atmospheric moisture (e.g., humidity), the carbonyl-difluoride hydrolyzes to generate carbon dioxide (CO_2) and hydrogen fluoride (HF). The hydrogen fluoride (HF) will then hydrate to form concentrated hydrofluoric acid (HF aq), which is a corrosive agent that reacts with metal and metal oxides.

Scavenger/Dopant – Antimony oxide (Sb_2O_3) is known for its ability to scavenge the decomposed HF, preventing wires from the corrosive attack by the decomposed HF, and wire manufacturers heavily dope the fluoropolymer insulation with antimony oxide to reduce the amount of outgassing. However, while the amount of antimony oxide in the insulation might be able to reduce the amount of outgassing and the resultant corrosion in the short term, outgassing and corrosion would eventually occur after the antimony oxide's scavenging capacity is exhausted/overwhelmed.

ETFE (Tefzel™) – While fluorine outgassing is a concern for all fluoropolymer insulations, ethylene tetrafluoroethylene (ETFE) and cross-linked ethylene tetrafluoroethylene (XL-ETFE) have been reported to have a higher evolution rate, possibly due to the blending and extrusion processes typically used for this polymer.

1 GENERAL REQUIREMENTS

1.1 Scope This document introduces design concepts, guidelines, procedures, practices, process attributes, and recommendations for the control and mitigation of performance and reliability risks associated with the use of fluoropolymer-insulated wire and cable in the manufacture of electrical and electronic assemblies, including optical and metallic cable and wiring harness assemblies, and elements thereof.

1.2 Purpose The intent of this document is to provide guidelines and a template for the development and implementation of a White Plague Control Plan (WPCP).

For purposes of this document:

- The Designer is the design agent for the User.
- The User is the individual, organization, company, contractually designated authority, or agency responsible for the procurement or design of electrical / electronic / electromechanical (EEE) hardware and having the authority to define the class of equipment and any variation or restrictions to the requirements of this document (e.g., the originator / custodian of the contract detailing these requirements). The User is considered the Design Authority.
- The Supplier is considered the individual, organization, or company which provides the Manufacturer (assembler) components (e.g., electrical, electronic, electromechanical, mechanical, printed boards, etc.), and/or materials (e.g., solder, flux, cleaning agents, etc.).
- The Manufacturer is considered the entity that provides a service or product to the User.

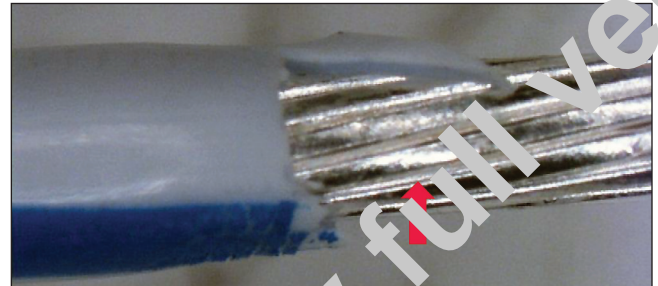


Figure 1-1 White Plague (Fluorine Attack)

Note white frosted section on silver coating

(Photo Courtesy of NACM)